Search Notes			

Applica	tion/Control No.	Applicant(s)/Patent Reexamination	under
09/889	,380	NAKAMURA ET AL	
Examir	er	Art Unit	
Annan	Q. Shang	2623	

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Class	Subclass	Date	Examiner
725	80,131,13 9,151	3/14/2007	A.S
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